Search Notes

Application/Control No.		Applicant(s)/Patent under Reexamination	
10/542,505	•	WENZLER, AXEL	
Examiner		Art Unit	
Toan M. Le		2863	

SEARCHED					
Class	Subclass	Date	Examiner		
702	1,94,150	2/8/2007	TL		
702	151	2/8/2007	TL		
324	207.24	2/8/2007	TL		
324	207.25	2/8/2007	TL		
73	1.75	2/8/2007	TL		
73	862.326	2/8/2007	TL		
Above	Updated	9/6/2007	TL		
73	862.08	9/6/2007	TL		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
702	1	9/6/2007	TL		
73	862.326	9/6/2007	TL		
		-			
Interference Search History Printout		9/6/2007	TL		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Phase Angular Position Linear Rotational Displacement Matrix Transform Scan Sense Coefficient	2/8/2007	TL
702/1,94,150,151; 324/207.24,207.25; 73/1.75,862.326 (Phase Angular Position Linear Rotational Displacement Matrix)	2/8/2007	TL
East- See Search History Printout	2/8/2007	TL
702/1,94,150,151; 324/207.24,207.25; 73/1.75,862.326,862.08 (Phase Angle Linear Rotation Displace)	9/6/2007	TL
Phase Angle Linear Rotation Displace Matrix Quantize Sensor	9/6/2007	TL
East- See Search History Printout	9/6/2007	TL